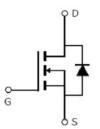


Main Product Characteristics

V _{DSS}	75V
R _{DS} (on)	6.5mΩ(typ.)
I _D	85A







TO-220

Marking and Pin
Assignment

Schematic Diagram

Features and Benefits

- Advanced MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 175°C operating temperature



Description

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in power switching application and a wide variety of other applications.

Absolute Max Rating

Symbol	Parameter	Max.	Units	
I _D @ TC = 25°C	= 25°C Continuous Drain Current, V _{GS} @ 10V①			
I _D @ TC = 100°C	© TC = 100°C Continuous Drain Current, V _{GS} @ 10V①		Α	
I _{DM}	Pulsed Drain Current②	340		
D 070 0500	Power Dissipation③	300	W	
P _D @TC = 25°C	Linear Derating Factor	2	W/°C	
V _{DS}	Drain-Source Voltage		V	
V _{GS}	V _{GS} Gate-to-Source Voltage		V	
E _{AS}	E _{AS} Single Pulse Avalanche Energy @ L=0.3mH		mJ	
I _{AS}	Avalanche Current @ L=0.3mH	55	Α	
T _J T _{STG}	T _{STG} Operating Junction and Storage Temperature Range		°C	



Thermal Resistance

Symbol	Characteristics	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-case③	_	0.5	°C /W
В	Junction-to-ambient (t \leq 10s) (4)	_	62	°C /W
$R_{\theta JA}$	Junction-to-Ambient (PCB mounted, steady-state) ④	_	40	°C /W

Electrical Characteristics @TA=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source breakdown voltage	75	_	_	V	V _{GS} = 0V, ID = 250μA
D	Rps(on) Static Drain-to-Source on-resistance		6.5	10	0	V _{GS} =10V,I _D = 40A
$R_{DS(on)}$	Static Drain-to-Source on-resistance	_	11.1	_	mΩ	T _J = 125°C
V	Cata threshold voltage	2	_	4	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
$V_{GS(th)}$	Gate threshold voltage	_	2.06	_	V	T _J = 125°C
1	Drain to Course leakers surrent	_	_	1		$V_{DS} = 75V, V_{GS} = 0V$
I _{DSS}	Drain-to-Source leakage current	_	_	50	μA	T _J = 125°C
	Cata ta Causaa famuand laakana	_	_	100	A	V _{GS} =25V
I_{GSS}	Gate-to-Source forward leakage	_	_	-100	nA	V _{GS} = -25V
Qg	Total gate charge	_	80	_		I _D = 80A,
Q _{gs}	Gate-to-Source charge	_	19	_	nC	V _{DS} =64V,
Q_{gd}	Gate-to-Drain("Miller") charge	_	27	_		V _{GS} = 10V
t _{d(on)}	Turn-on delay time	_	25	_		
t _r	Rise time	_	20	_		V _{GS} =10V, VDS=38V,
t _{d(off)}	Turn-Off delay time	_	71	_	ns	R _{GEN} =6Ω,ID=42A
t _f	Fall time	_	47	_		
C _{iss}	Input capacitance	_	5961	_		V _{GS} = 0V
Coss	Output capacitance	_	452	_	pF	$V_{DS} = 30V$
C _{rss}	Reverse transfer capacitance	_	169	_		f = 1MHz

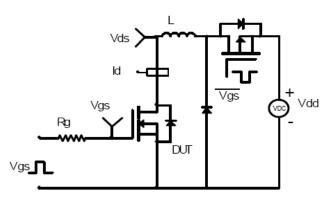
Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
1	Continuous Source Current			85	Α	MOSFET symb
I _S	(Body Diode)	_	_	65	A	showing the
I _{SM}	Pulsed Source Current			340	А	integral reverse
	(Body Diode)	_	_			p-n junction diode.
V _{SD}	Diode Forward Voltage	_	0.8	1	V	I _S =20A, V _{GS} =0V
t _{rr}	Reverse Recovery Time	_	37	_	ns	$T_J = 25^{\circ}\text{C}, I_F = 40\text{A},$
Q _{rr}	Reverse Recovery Charge	_	50	_	nC	di/dt = 100A/µs

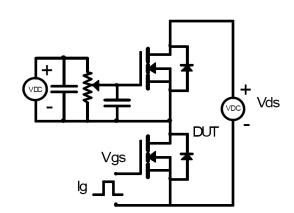


Test circuits and Waveforms

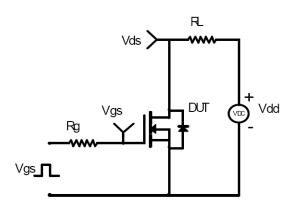
EAS Test Circuit



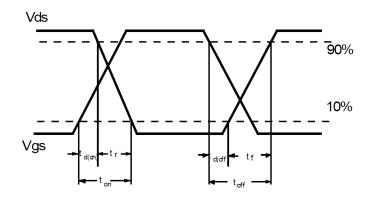
Gate charge test circuit



Switching Time Test Circuit



Switching Waveforms

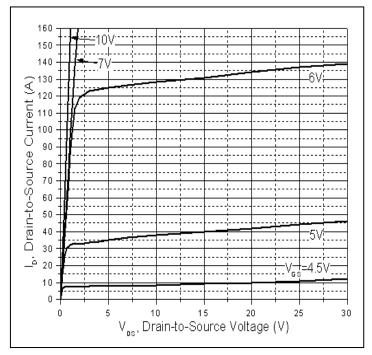


Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- ③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.
- 4The value of $R_{\texttt{6JA}}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C



Typical electrical and thermal characteristics



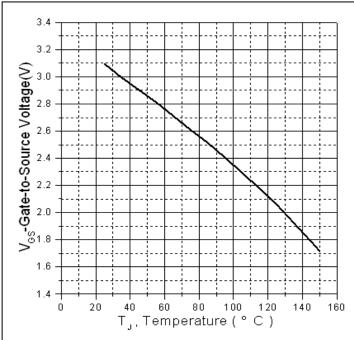
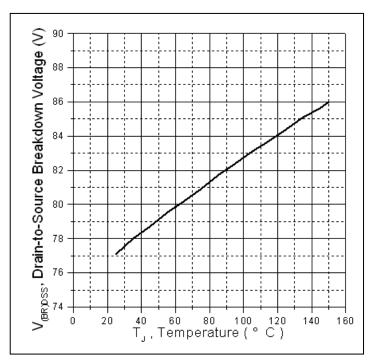


Figure 1: Typical Output Characteristics







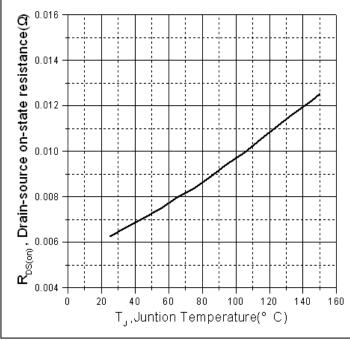
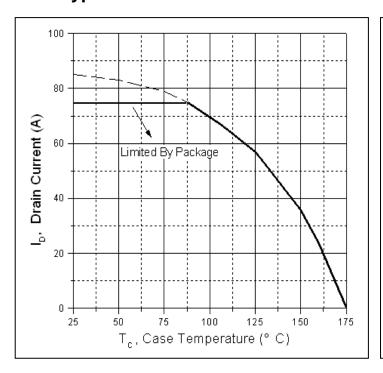


Figure 4: Normalized On-Resistance Vs. Case Temperature



Typical electrical and thermal characteristics



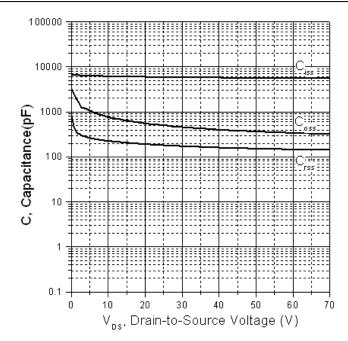


Figure 5. Maximum Drain Current Vs. Case Temperature

Figure 6.Typical Capacitance Vs. Drain-to-Source Voltage

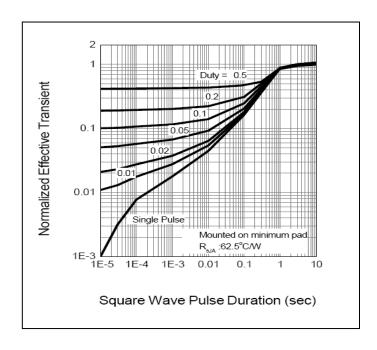
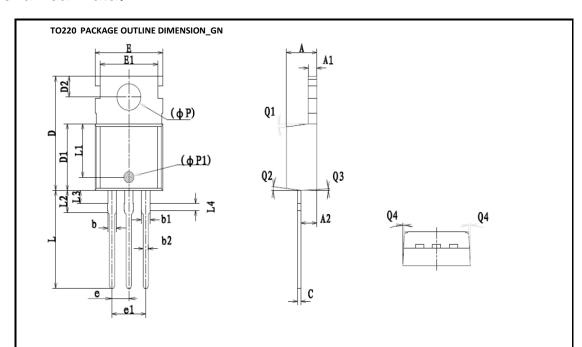


Figure 7. Maximum Effective Transient Thermal Impedance, Junction-to-Case



Mechanical Data:



Complete	Dime	nsion In Millin	neters	Dimension In Inches			
Symbol	Min	Nom	Max	Min	Nom	Max	
Α	4.400	4.550	4.700	0.173	0.179	0.185	
A1	1.270	1.300	1.330	0.050	0.051	0.052	
A2	2.240	2.340	2.440	0.088	0.092	0.096	
b	_	1.270	I	-	0.050	-	
b1	1.270	1.370	1.470	0.050	0.054	0.058	
b2	0.750	0.800	0.850	0.030	0.031	0.033	
С	0.480	0.500	0.520	0.019	0.020	0.021	
D	15.100	15.400	15.700	0.594	0.606	0.618	
D1	8.800	8.900	9.000	0.346	0.350	0.354	
D2	2.730	2.800	2.870	0.107	0.110	0.113	
Е	9.900	10.000	10.100	0.390	0.394	0.398	
E1	-	8.700	ı	-	0.343	-	
ΦР	3.570	3.600	3.630	0.141	0.142	0.143	
ФР1	1.400	1.500	1.600	0.055	0.059	0.063	
е		2.54BSC		0.1BSC			
e1		5.08BSC		0.2BSC			
L	13.150	13.360	13.570	0.518	0.526	0.534	
L1		7.35REF	-		0.29REF	•	
L2	2.900	3.000	3.100	0.114	0.118	0.122	
L3	1.650	1.750	1.850	0.065	0.069	0.073	
L4	0.900	1.000	1.100	0.035	0.039	0.043	
Q1	5 ⁰	7 ⁰	9 ⁰	5 ⁰	7 ⁰	90	
Q2	5 ⁰	7 ⁰	9°	5 ⁰	7 ⁰	90	
Q3	5 ⁰	7 ⁰	9 ⁰	5 ⁰	7 ⁰	90	
Q4	1 ⁰	3 ⁰	5 ⁰	1 ⁰	3 ⁰	5 ⁰	



Ordering and Marking Information

Device Marking: SSF7610

Package (Available)
TO-220
Operating Temperature Range
C: -55 to 150 °C

Devices per Unit

Package	Units/	Tubes/Inner	Units/Inner	Inner	Units/Carton
Type	Tube	Box	Box	Boxes/Carton	Box
				Box	

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High	T _j =125℃ to 150℃ @	168 hours	3 lots x 77 devices
Temperature	80% of Max	500 hours	
Reverse	V _{DSS} /V _{CES} /VR	1000 hours	
Bias(HTRB)			
High	T _j =150℃ @ 100% of	168 hours	3 lots x 77 devices
Temperature	Max V _{GSS}	500 hours	
Gate		1000 hours	
Bias(HTGB)			



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